



# SLP120N06T

## 60V N-Channel MOSFET

### General Description

This Power MOSFET is produced using Maplesemi's advanced TRENCH technology.

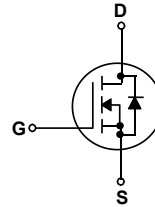
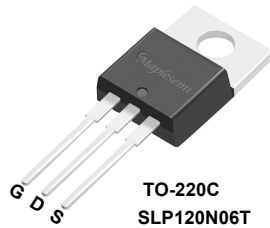
This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

### Application

- PWM Application
- Load Switch
- Power Management

### Features

- 120A, 60V,  $R_{DS(on)Typ} = 4.4m\Omega @ V_{GS} = 10V$
- Very Low On-resistance RDS(ON)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol          | Parameter  | SLP120N06T  | Units                     |
|-----------------|--|-------------|---------------------------|
| $V_{DSS}$       | Drain-Source Voltage   | 60          | V                         |
| $I_D$           | Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )                          | 120         | A                         |
|                 | - Continuous ( $T_C = 100^\circ\text{C}$ )                                       | 78          | A                         |
| $I_{DM}$        | Drain Current - Pulsed (Note 1)  | 360         | A                         |
| $V_{GSS}$       | Gate-Source Voltage  | $\pm 20$    | V                         |
| EAS             | Single Pulsed Avalanche Energy (Note 2)  | 564         | mJ                        |
| $E_{AR}$        | Repetitive Avalanche Energy (Note 1)   | 245         | mJ                        |
| dv/dt           | Peak Diode Recovery dv/dt (Note 3)   | 4.5         | V/ns                      |
| $P_D$           | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                                   | 320         | W                         |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case   | 0.40        | $^\circ\text{C}/\text{W}$ |
| $T_J, T_{STG}$  | Operating and Storage Temperature Range  | -55 to +150 | $^\circ\text{C}$          |
| $T_L$           | Maximum lead temperature for soldering purposes,<br>1/8" from case for 5 seconds | 300         | $^\circ\text{C}$          |

\* Drain current limited by maximum junction temperature.

## Package Marking

| Part Number | Top Marking | Package | Packing Method | MOQ  | QTY  |
|-------------|-------------|---------|----------------|------|------|
| SLP120N06T  | SLP120N06T  | TO-220C | Tube           | 1000 | 5000 |

## Electrical Characteristics

$T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

### Off Characteristics

|                                      |   |   |    |      |      |                           |
|--------------------------------------|---|---|----|------|------|---------------------------|
| $BV_{DSS}$                           | Drain-Source Breakdown Voltage            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$               | 60 | --   | --   | V                         |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$ | -- | 0.06 | --   | $\text{V}/^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$                       | -- | --   | 1    | $\mu\text{A}$             |
|                                      |   | $V_{DS} = 48\text{ V}, T_C = 150^\circ\text{C}$                   | -- | --   | 10   | $\mu\text{A}$             |
| $I_{GSSF}$                           | Gate-Body Leakage Current, Forward        | $V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$                       | -- | --   | 100  | nA                        |
| $I_{GSSR}$                           | Gate-Body Leakage Current, Reverse        | $V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$                      | -- | --   | -100 | nA                        |

### On Characteristics

|              |                                   |   |    |     |     |            |
|--------------|-----------------------------------|---|----|-----|-----|------------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | 2  | --  | 4   | V          |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 10\text{ V}, I_D = 30\text{ A}$       | -- | 4.4 | 5.5 | m $\Omega$ |

### Dynamic Characteristics

|            |                              |  |    |      |    |    |
|------------|------------------------------|--|----|------|----|----|
| $C_{iss}$  | Input Capacitance            | $V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ | -- | 5540 | -- | pF |
| $C_{oss}$  | Output Capacitance           |  | -- | 420  | -- | pF |
| $C_{riss}$ | Reverse Transfer Capacitance |  | -- | 390  | -- | pF |

### Switching Characteristics

|              |                     |   |    |     |    |          |
|--------------|---------------------|---|----|-----|----|----------|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 30\text{ V}, I_D = 60\text{ A},$<br>$R_G = 1\text{ }\Omega, R_L = 0.4\text{ }\Omega$<br>(Note 4, 5) | -- | 17  | -- | ns       |
| $t_r$        | Turn-On Rise Time   |   | -- | 16  | -- | ns       |
| $t_{d(off)}$ | Turn-Off Delay Time |   | -- | 35  | -- | ns       |
| $t_f$        | Turn-Off Fall Time  |   | -- | 13  | -- | ns       |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 30\text{ V}, I_D = 60\text{ A},$<br>$V_{GS} = 10\text{ V}$<br>(Note 4, 5)                           | -- | 141 | -- | nC       |
| $Q_{gs}$     | Gate-Source Charge  |   | -- | 37  | -- | nC       |
| $Q_{gd}$     | Gate-Drain Charge   |   | -- | 47  | -- | nC       |
| $R_G$        | Gate Resistance     | $f = 1\text{ MHz}$  | -- | 1.7 | -- | $\Omega$ |

### Drain-Source Diode Characteristics and Maximum Ratings

|          |   |   |    |     |     |    |
|----------|---|---|----|-----|-----|----|
| $I_S$    | Maximum Continuous Drain-Source Diode Forward Current | --  | -- | 120 | A   |    |
| $I_{SM}$ | Maximum Pulsed Drain-Source Diode Forward Current     | --  | -- | 360 | A   |    |
| $V_{SD}$ | Drain-Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}, I_S = 60\text{ A}$        | -- | --  | 1.4 | V  |
| $t_{rr}$ | Reverse Recovery Time                                 | $V_{GS} = 0\text{ V}, I_S = 60\text{ A},$       | -- | 55  | --  | ns |
| $Q_{rr}$ | Reverse Recovery Charge                               | $di_F / dt = 100\text{ A}/\mu\text{s}$ (Note 4) | -- | 70  | --  | nC |

#### Notes:

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS} = I_D, V_{DD} = 30\text{ V}, R_G = 25\text{ }\Omega$ , Starting  $T_J = 25^\circ\text{C}$
- $I_{SD} \leq I_D, di/dt \leq 200\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
- Pulse Test : Pulse width  $\leq 300\text{ }\mu\text{s}$ , Duty cycle  $\leq 2\%$
- Essentially independent of operating temperature

### N- Channel Typical Characteristics

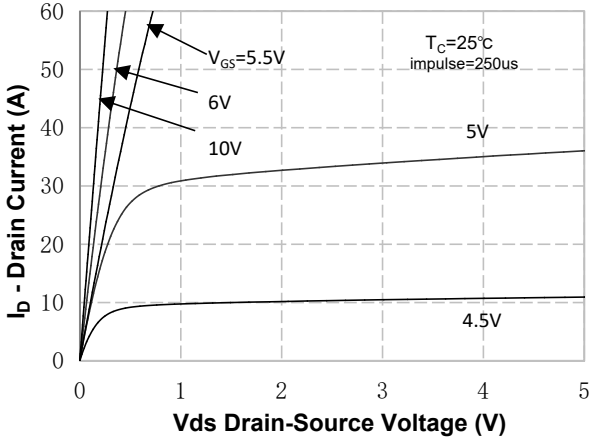


Figure 1. On-Region Characteristics

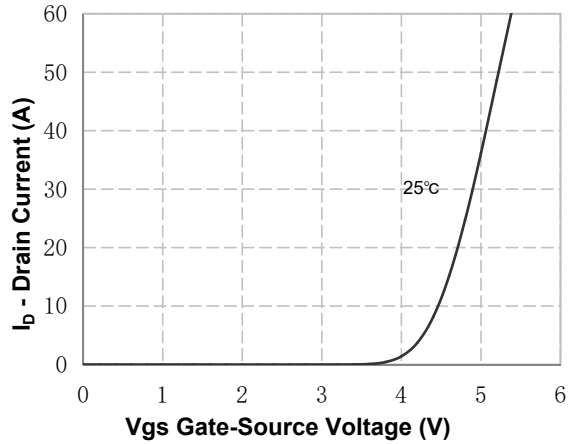


Figure 2. Transfer Characteristics

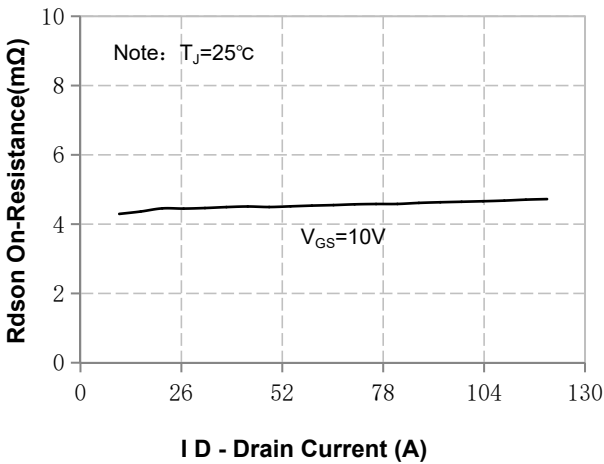


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

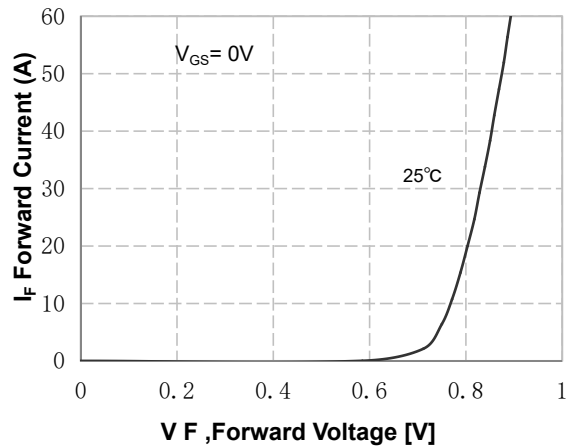


Figure 4. Body Diode Forward Voltage Variation with Source Current

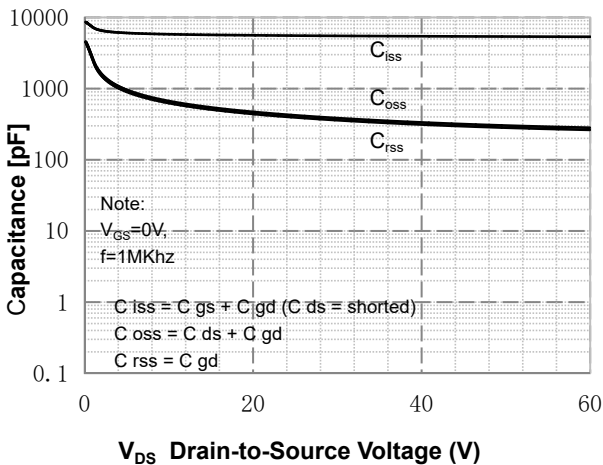


Figure 5. Capacitance Characteristics

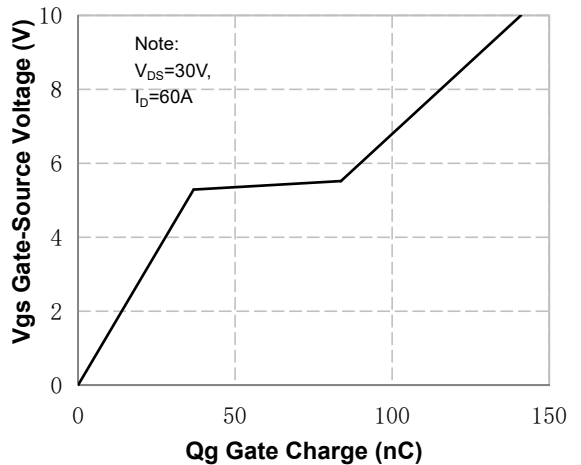
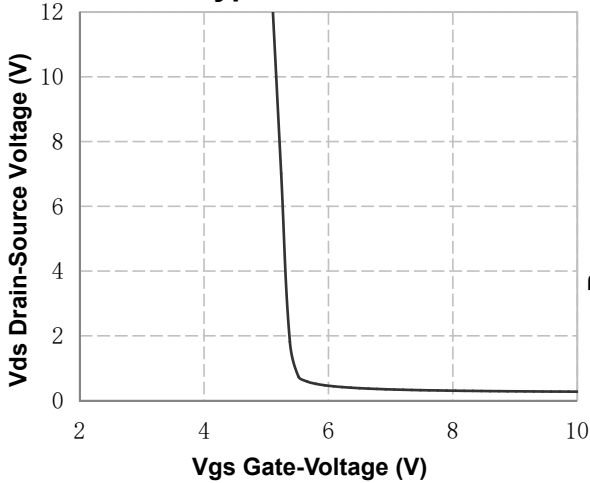
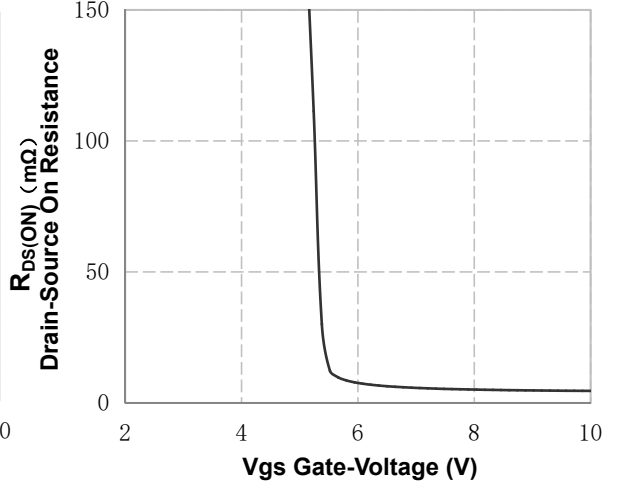


Figure 6. Gate Charge Characteristics

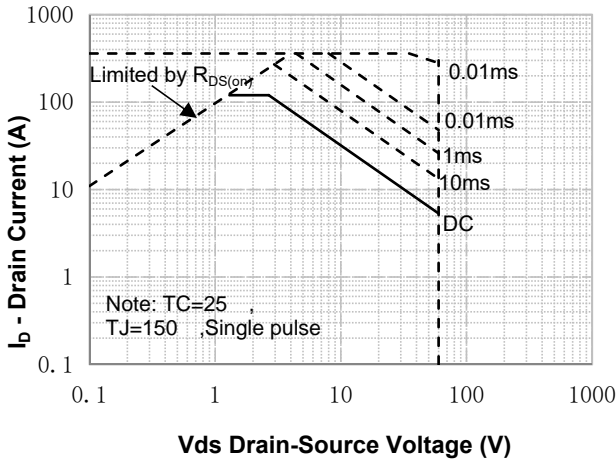
**N- Channel Typical Characteristics** (Continued)



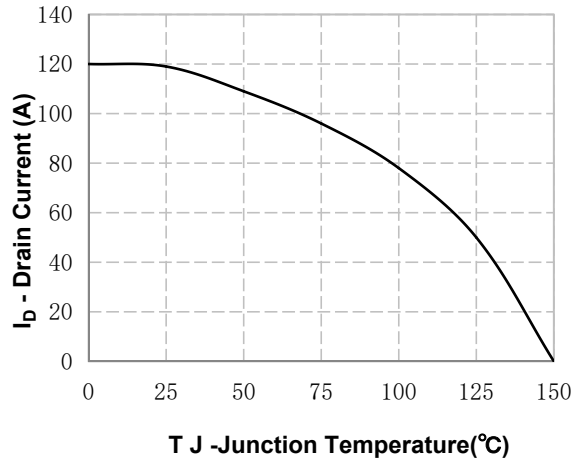
**Figure 7. Vds Drain-Source Voltage vs Gate Voltage**



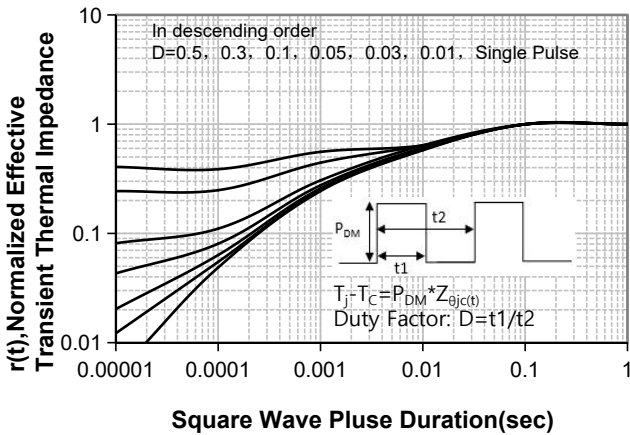
**Figure 8. On-Resistance vs Gate Voltage**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Continuous Drain Current vs Case Temperature**

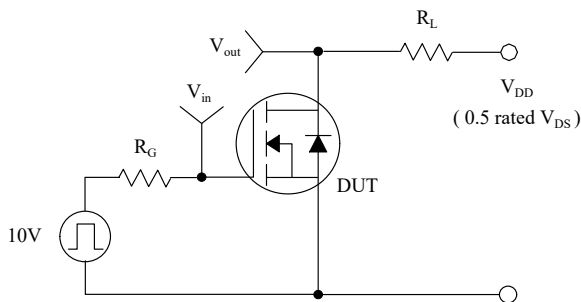


**Figure 11. Transient Thermal Response Curve**

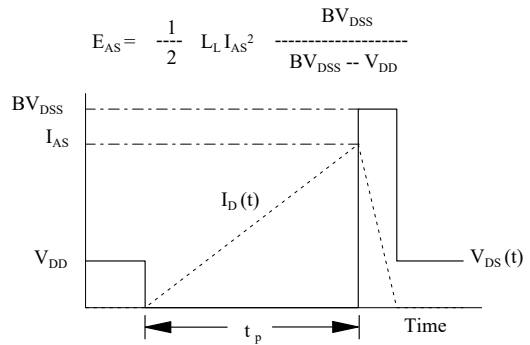
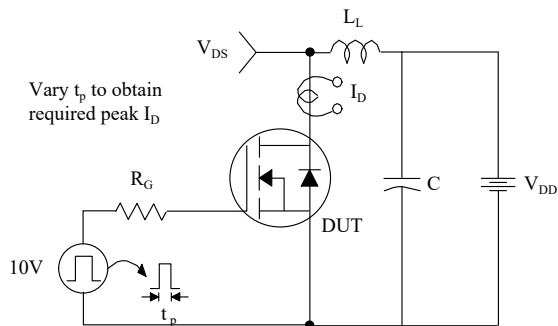
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



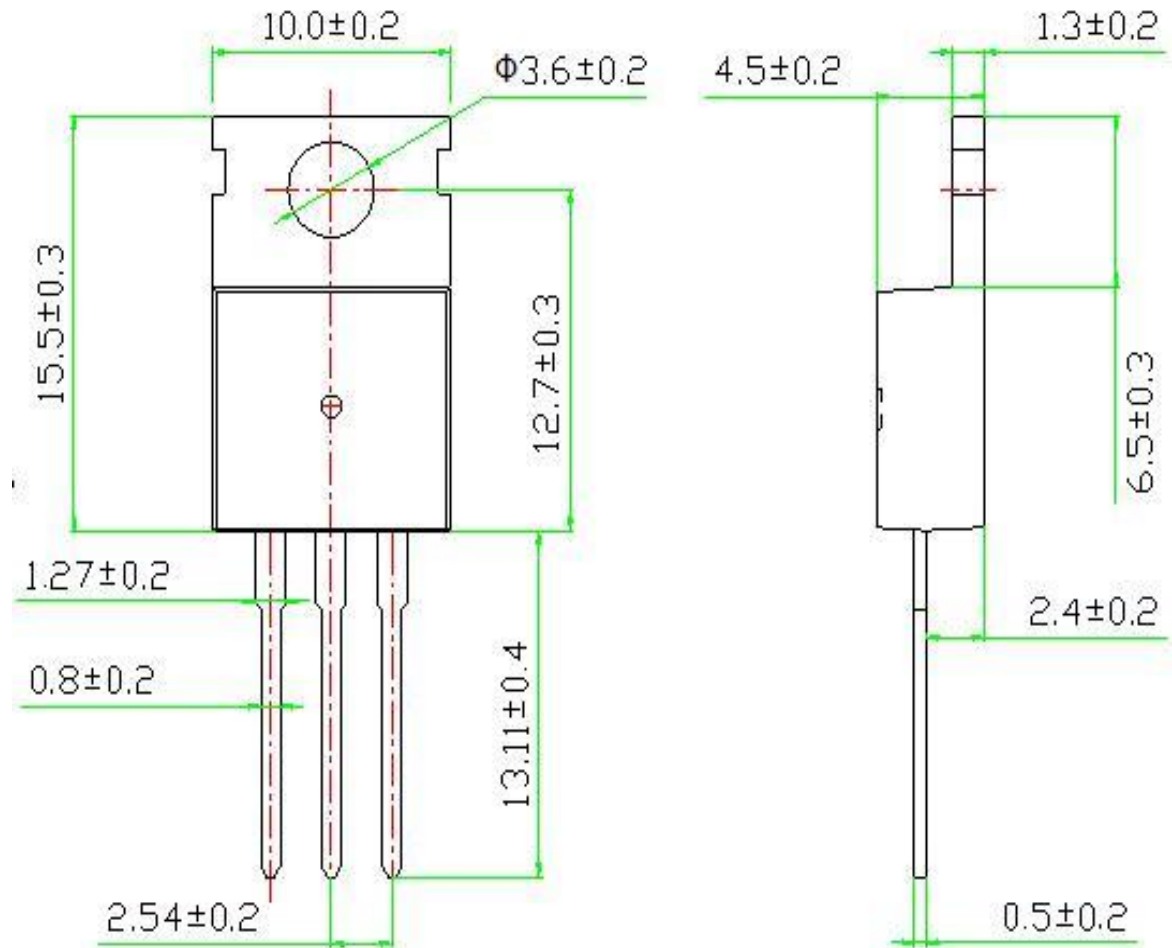
### Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



## TO-220C OUTLINE



## NOTE:

1 The plastic package is not marked as smooth surface  $R_a = 0.1$ ; Subglossy surface  $R_a = 0.8$

2. Undeclared tolerance  $\pm 0.25$ , Unmarked fillet  $R_{max} = 0.25$